



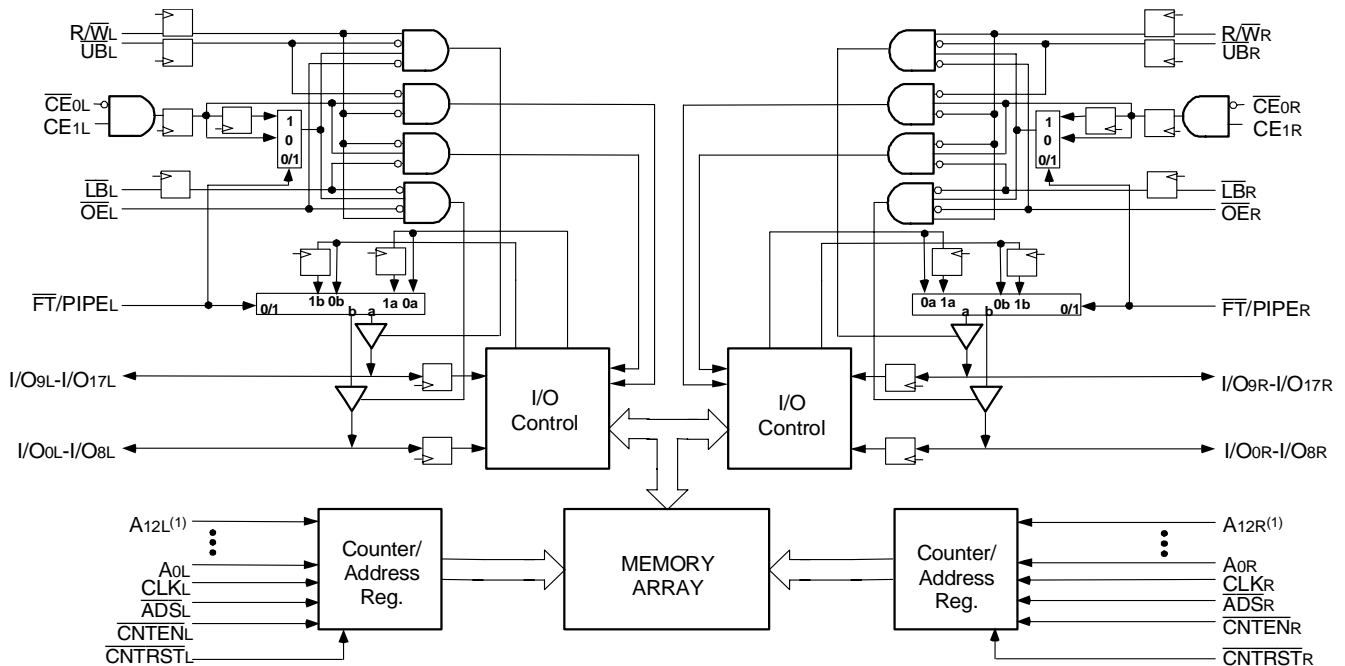
# HIGH-SPEED 8/4K x 18 SYNCHRONOUS PIPELINED DUAL-PORT STATIC RAM

IDT709359/49L

## Features

- ◆ True Dual-Ported memory cells which allow simultaneous access of the same memory location
  - ◆ High-speed clock to data access
    - Commercial: 6.5/7.5/9ns (max.)
    - Industrial: 7.5ns (max.)
  - ◆ Low-power operation
    - IDT709359/49L
    - Active: 925mW (typ.)
    - Standby: 2.5mW (typ.)
  - ◆ Flow-Through or Pipelined output mode on either Port via the FT/PIPEL pins
  - ◆ Counter enable and reset features
  - ◆ Dual chip enables allow for depth expansion without additional logic
- ◆ Full synchronous operation on both ports
    - 3.5ns setup to clock and 0ns hold on all control, data, and address inputs
    - Data input, address, and control registers
    - Fast 6.5ns clock to data out in the Pipelined output mode
    - Self-timed write allows fast cycle time
    - 10ns cycle time, 100MHz operation in Pipelined output mode
  - ◆ Separate upper-byte and lower-byte controls for multiplexed bus and bus matching compatibility
  - ◆ TTL-compatible, single 5V (±10%) power supply
  - ◆ Industrial temperature range (–40°C to +85°C) is available for 83 MHz
  - ◆ Available in a 100-pin Thin Quad Flatpack (TQFP) package and a 100-pin fine pitch Ball Grid Array (fpBGA)

## Functional Block Diagram



5633 drw 01

### NOTE:

1. A12 is a NC for IDT709349.

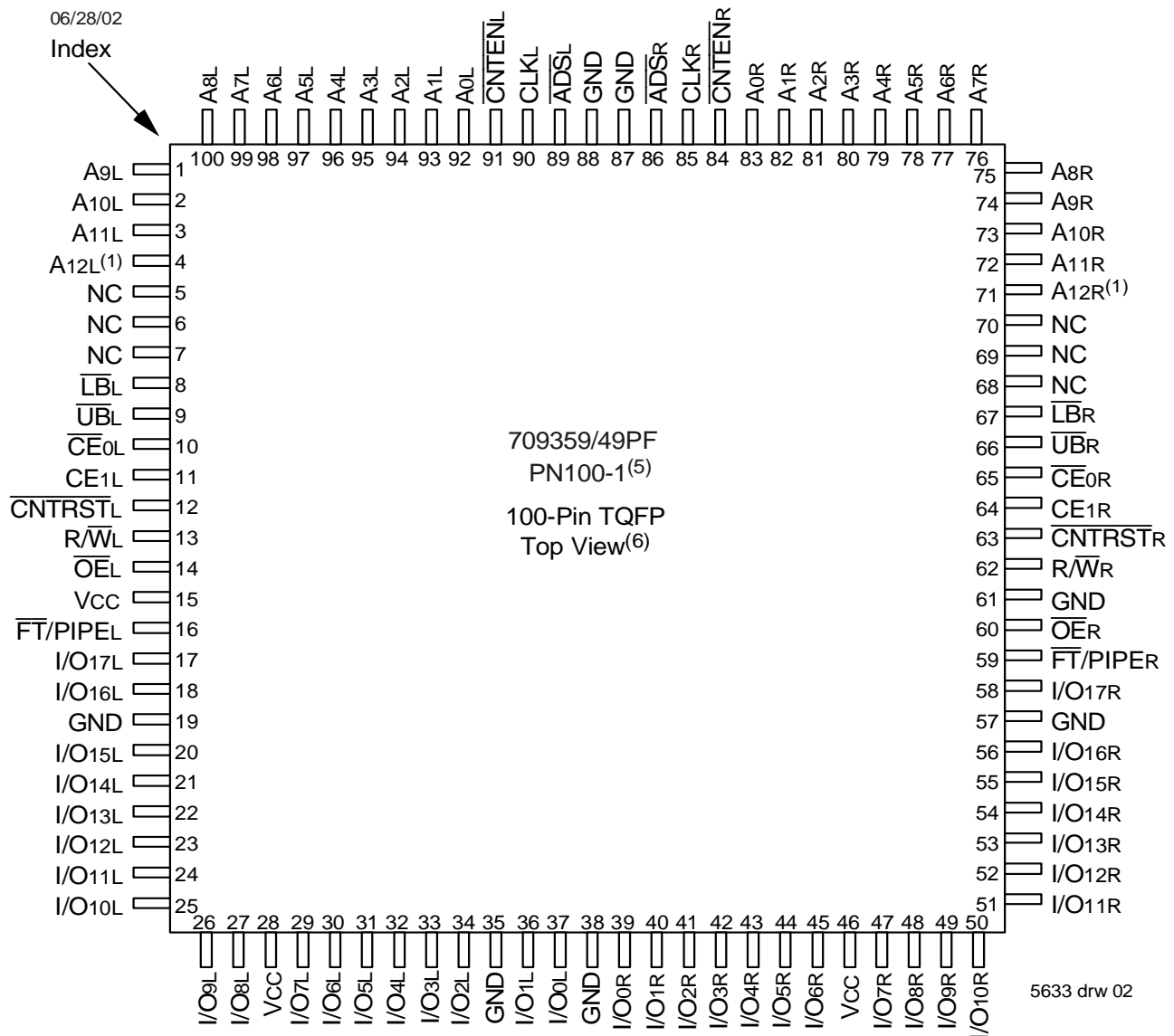
AUGUST 2003

## Description

The IDT709359/49 is a high-speed 8/4K x 18 bit synchronous Dual-Port RAM. The memory array utilizes Dual-Port memory cells to allow simultaneous access of any address from both ports. Registers on control, data, and address inputs provide minimal setup and hold times. The timing latitude provided by this approach allows systems to be designed with very short cycle times.

With an input data register, the IDT709359/49 has been optimized for applications having unidirectional or bidirectional data flow in bursts. An automatic power down feature, controlled by  $\overline{CE_0}$  and  $CE_1$ , permits the on-chip circuitry of each port to enter a very low standby power mode. Fabricated using IDT's CMOS high-performance technology, these devices typically operate on only 925mW of power.

## Pin Configurations<sup>(1,2,3,4)</sup>



### NOTES:

1. A12 is a NC for IDT709349.
2. All Vcc pins must be connected to power supply.
3. All GND pins must be connected to ground.
4. Package body is approximately 14mm x 14mm x 1.4mm
5. This package code is used to reference the package diagram.
6. This text does not indicate orientation of the actual part-marking.

**Pin Configurations (con't.)<sup>(1,2,3,4)</sup>**

709359/49BF

BF100<sup>(5)</sup>

100-Pin fpBGA

Top View<sup>(6)</sup>

06/28/02

A1 A8R	A2 A11R	A3 $\overline{UBR}$	A4 $\overline{CNTRSTR}$	A5 GND	A6 GND	A7 GND	A8 I/O13R	A9 I/O10R	A10 I/O17R
B1 A6R	B2 A7R	B3 A10R	B4 A12R <sup>(1)</sup>	B5 R/ $\overline{WR}$	B6 $\overline{OER}$	B7 PL/ $\overline{FTR}$	B8 I/O12R	B9 I/O9R	B10 I/O6R
C1 A3R	C2 A4R	C3 A5R	C4 A9R	C5 CE1R	C6 I/O16R	C7 I/O15R	C8 I/O11R	C9 I/O7R	C10 I/O3R
D1 A0R	D2 CLKR	D3 A1R	D4 A2R	D5 $\overline{LBR}$	D6 $\overline{CE0R}$	D7 I/O14R	D8 I/O8R	D9 I/O5R	D10 I/O1R
E1 GND	E2 $\overline{ADSR}$	E3 $\overline{CNTENR}$	E4 A1L	E5 $\overline{ADSL}$	E6 GND	E7 I/O4R	E8 I/O2R	E9 I/O0R	E10 VCC
F1 GND	F2 CLKL	F3 A0L	F4 A3L	F5 VCC	F6 GND	F7 VCC	F8 I/O2L	F9 I/O1L	F10 I/O0L
G1 $\overline{CNTENL}$	G2 A4L	G3 A7L	G4 $\overline{UBL}$	G5 GND	G6 I/O13L	G7 NC	G8 I/O4L	G9 GND	G10 I/O3L
H1 A2L	H2 A6L	H3 A11L	H4 $\overline{CE0L}$	H5 $\overline{CNTRSTL}$	H6 I/O15L	H7 I/O9L	H8 I/O7L	H9 I/O6L	H10 I/O5L
J1 A5L	J2 A9L	J3 A12L <sup>(1)</sup>	J4 R/ $\overline{WL}$	J5 $\overline{OEL}$	J6 PL/ $\overline{FTL}$	J7 I/O12L	J8 I/O10L	J9 GND	J10 I/O8L
K1 A8L	K2 A10L	K3 $\overline{LBL}$	K4 CE1L	K5 VCC	K6 VCC	K7 I/O16L	K8 I/O14L	K9 I/O11L	K10 I/O17L

5633 drw 03

**NOTES:**

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3. All GND pins must be connected to ground.
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5. This package code is used to reference the package diagram.
6. This text does not indicate orientation of the actual part-marking.

## Pin Names

Left Port	Right Port	Names
$\overline{CE}_{0L}$ , $CE_{1L}$	$\overline{CE}_{0R}$ , $CE_{1R}$	Chip Enables <sup>(3)</sup>
$R/\overline{W}_L$	$R/\overline{W}_R$	Read/Write Enable
$\overline{OE}_L$	$\overline{OE}_R$	Output Enable
$A_{0L} - A_{12L}^{(1)}$	$A_{0R} - A_{12R}^{(1)}$	Address
$I/O_{0L} - I/O_{17L}$	$I/O_{0R} - I/O_{17R}$	Data Input/Output
CLKL	CLKR	Clock
$\overline{UB}_L$	$\overline{UB}_R$	Upper Byte Select <sup>(2)</sup>
$\overline{LB}_L$	$\overline{LB}_R$	Lower Byte Select <sup>(2)</sup>
$\overline{ADS}_L$	$\overline{ADS}_R$	Address Strobe
$\overline{CNTEN}_L$	$\overline{CNTEN}_R$	Counter Enable
$\overline{CNRST}_L$	$\overline{CNRST}_R$	Counter Reset
$\overline{FT}/\overline{PIPE}_L$	$\overline{FT}/\overline{PIPE}_R$	Flow-Through/Pipeline
Vcc		Power (5V)
GND		Ground (0V)

5633 tbl 01

### NOTES:

1. A<sub>12</sub> is a NC for IDT709349.
2.  $\overline{LB}$  and  $\overline{UB}$  are single buffered regardless of state of  $\overline{FT}/\overline{PIPE}$ .
3.  $\overline{CE}_0$  and  $CE_1$  are single buffered when  $\overline{FT}/\overline{PIPE} = V_{IL}$ ,  $\overline{CE}_0$  and  $CE_1$  are double buffered when  $\overline{FT}/\overline{PIPE} = V_{IH}$ , i.e. the signals take two cycles to deselect.

## Truth Table I—Read/Write and Enable Control<sup>(1,2,3)</sup>

$\overline{OE}$	CLK	$\overline{CE}_0^{(5)}$	$CE_1^{(5)}$	$\overline{UB}^{(4)}$	$\overline{LB}^{(4)}$	R/ $\overline{W}$	Upper Byte I/O <sub>9-17</sub>	Lower Byte I/O <sub>0-8</sub>	Mode
X	↑	H	X	X	X	X	High-Z	High-Z	Deselected—Power Down
X	↑	X	L	X	X	X	High-Z	High-Z	Deselected—Power Down
X	↑	L	H	H	H	X	High-Z	High-Z	Both Bytes Deselected
X	↑	L	H	L	H	L	DATA <sub>IN</sub>	High-Z	Write to Upper Byte Only
X	↑	L	H	H	L	L	High-Z	DATA <sub>IN</sub>	Write to Lower Byte Only
X	↑	L	H	L	L	L	DATA <sub>IN</sub>	DATA <sub>IN</sub>	Write to Both Bytes
L	↑	L	H	L	H	H	DATA <sub>OUT</sub>	High-Z	Read Upper Byte Only
L	↑	L	H	H	L	H	High-Z	DATA <sub>OUT</sub>	Read Lower Byte Only
L	↑	L	H	L	L	H	DATA <sub>OUT</sub>	DATA <sub>OUT</sub>	Read Both Bytes
H	X	L	H	X	X	X	High-Z	High-Z	Outputs Disabled

5633 tbl 02

### NOTES:

1. "H" = V<sub>IH</sub>, "L" = V<sub>IL</sub>, "X" = Don't Care.
2.  $\overline{ADS}$ ,  $\overline{CNTEN}$ ,  $\overline{CNRST} = X$ .
3.  $\overline{OE}$  is an asynchronous input signal.
4.  $\overline{LB}$  and  $\overline{UB}$  are single buffered regardless of state of  $\overline{FT}/\overline{PIPE}$ .
5.  $\overline{CE}_0$  and  $CE_1$  are single buffered when  $\overline{FT}/\overline{PIPE} = V_{IL}$ .  $\overline{CE}_0$  and  $CE_1$  are double buffered when  $\overline{FT}/\overline{PIPE} = V_{IH}$ , i.e. the signals take two cycles to deselect.

**Truth Table II—Address Counter Control<sup>(1,2)</sup>**

External Address	Previous Internal Address	Internal Address Used	CLK	$\overline{ADS}$	$\overline{CNTEN}$	$\overline{CNRST}$	I/O <sup>(3)</sup>	MODE
An	X	An	↑	L <sup>(4)</sup>	X	H	D <sub>IO</sub> (n)	External Address Used
X	An	An + 1	↑	H	L <sup>(5)</sup>	H	D <sub>IO</sub> (n+1)	Counter Enabled—Internal Address generation
X	An + 1	An + 1	↑	H	H	H	D <sub>IO</sub> (n+1)	External Address Blocked—Counter disabled (An + 1 reused)
X	X	A0	↑	X	X	L <sup>(4)</sup>	D <sub>IO</sub> (0)	Counter Reset to Address 0

**NOTES:**

- "H" = V<sub>IH</sub>, "L" = V<sub>IL</sub>, "X" = Don't Care.
- $\overline{CE0}$ ,  $\overline{LB}$ ,  $\overline{UB}$ , and  $\overline{OE}$  = V<sub>IL</sub>; CE<sub>1</sub> and R/W = V<sub>IH</sub>.
- Outputs configured in Flow-Through Output mode: if outputs are in Pipelined mode the data out will be delayed by one cycle.
- $\overline{ADS}$  and  $\overline{CNRST}$  are independent of all other signals including  $\overline{CE0}$ , CE<sub>1</sub>,  $\overline{UB}$  and  $\overline{LB}$ .
- The address counter advances if  $\overline{CNTEN}$  = V<sub>IL</sub> on the rising edge of CLK, regardless of all other signals including  $\overline{CE0}$ , CE<sub>1</sub>,  $\overline{UB}$  and  $\overline{LB}$ .

5633 tbl 03

**Recommended Operating Temperature and Supply Voltage<sup>(1)</sup>**

Grade	Ambient Temperature <sup>(1)</sup>	GND	V <sub>CC</sub>
Commercial	0°C to +70°C	0V	5.0V ± 10%
Industrial	-40°C to +85°C	0V	5.0V ± 10%

5633 tbl 04

**NOTES:**

- Industrial temperature: for specific speeds, packages and powers contact your sales office.
- This is the parameter T<sub>A</sub>. This is the "instant on" case temperature.

**Recommended DC Operating Conditions**

Symbol	Parameter	Min.	Typ.	Max.	Unit
V <sub>CC</sub>	Supply Voltage	4.5	5.0	5.5	V
GND	Ground	0	0	0	V
V <sub>IH</sub>	Input High Voltage	2.2	—	6.0 <sup>(1)</sup>	V
V <sub>IL</sub>	Input Low Voltage	-0.5 <sup>(2)</sup>	—	0.8	V

5633 tbl 05

**NOTES:**

- V<sub>TERM</sub> must not exceed V<sub>CC</sub> + 10%.
- V<sub>IL</sub> ≥ -1.5V for pulse width less than 10ns.

**Absolute Maximum Ratings<sup>(1)</sup>**

Symbol	Rating	Commercial & Industrial	Unit
V <sub>TERM</sub> <sup>(2)</sup>	Terminal Voltage with Respect to GND	-0.5 to +7.0	V
T <sub>BIAS</sub>	Temperature Under Bias	-55 to +125	°C
T <sub>STG</sub>	Storage Temperature	-65 to +150	°C
I <sub>OUT</sub>	DC Output Current	50	mA

5633 tbl 06

**NOTES:**

- Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
- V<sub>TERM</sub> must not exceed V<sub>CC</sub> + 10% for more than 25% of the cycle time or 10ns maximum, and is limited to ≤ 20mA for the period of V<sub>TERM</sub> ≥ V<sub>CC</sub> + 10%.

**Capacitance<sup>(1)</sup>****(T<sub>A</sub> = +25°C, f = 1.0MHz)**

Symbol	Parameter	Conditions <sup>(2)</sup>	Max.	Unit
C <sub>IN</sub>	Input Capacitance	V <sub>IN</sub> = 3dV	9	pF
C <sub>OUT</sub> <sup>(3)</sup>	Output Capacitance	V <sub>OUT</sub> = 3dV	10	pF

5633 tbl 07

**NOTES:**

- These parameters are determined by device characterization, but are not production tested.
- 3dV references the interpolated capacitance when the input and output switch from 0V to 3V or from 3V to 0V.
- C<sub>OUT</sub> also references C<sub>I/O</sub>.

## DC Electrical Characteristics Over the Operating Temperature Supply Voltage Range ( $V_{CC} = 5.0V \pm 10\%$ )

Symbol	Parameter	Test Conditions	709359/49L		Unit
			Min.	Max.	
$ I_{LI} $	Input Leakage Current <sup>(1)</sup>	$V_{CC} = 5.5V, V_{IN} = 0V$ to $V_{CC}$	—	5	$\mu A$
$ I_{LO} $	Output Leakage Current	$\overline{CE}_0 = V_H$ or $CE_1 = V_{IL}, V_{OUT} = 0V$ to $V_{CC}$	—	5	$\mu A$
$V_{OL}$	Output Low Voltage	$I_{OL} = +4mA$	—	0.4	V
$V_{OH}$	Output High Voltage	$I_{OH} = -4mA$	2.4	—	V

5633 tbl 08

**NOTE:**

- At  $V_{CC} \leq 2.0V$  input leakages are undefined.

## DC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range<sup>(3)</sup> ( $V_{CC} = 5V \pm 10\%$ )

Symbol	Parameter	Test Condition	Version	709359/49L6 Com'l Only		709359/49L7 Com'l & Ind		709359/49L9 Com'l Only		Unit
				Typ. <sup>(4)</sup>	Max.	Typ. <sup>(4)</sup>	Max.	Typ. <sup>(4)</sup>	Max.	
ICC	Dynamic Operating Current (Both Ports Active)	$\overline{CE}_L$ and $\overline{CE}_R = V_{IL}$ Outputs Disabled $f = f_{MAX}^{(1)}$	COM'L L	230	430	210	400	185	360	mA
			IND L	—	—	210	440	—	—	
ISB1	Standby Current (Both Ports - TTL Level Inputs)	$\overline{CE}_L = \overline{CE}_R = V_{IH}$ $f = f_{MAX}^{(1)}$	COM'L L	45	115	40	105	35	95	mA
			IND L	—	—	40	120	—	—	
ISB2	Standby Current (One Port - TTL Level Inputs)	$\overline{CE}_A = V_{IL}$ and $\overline{CE}_B = V_{IH}^{(3)}$ Active Port Outputs Disabled, $f = f_{MAX}^{(1)}$	COM'L L	150	235	135	220	120	205	mA
			IND L	—	—	135	235	—	—	
ISB3	Full Standby Current (Both Ports - CMOS Level Inputs)	Both Ports $CE_R$ and $\overline{CE}_L \geq V_{CC} - 0.2V$ $V_{IN} \geq V_{CC} - 0.2V$ or $V_{IN} \leq 0.2V, f = 0^{(2)}$	COM'L L	0.5	3.0	0.5	3.0	0.5	3.0	mA
			IND L	—	—	0.5	3.0	—	—	
ISB4	Full Standby Current (One Port - CMOS Level Inputs)	$\overline{CE}_A < 0.2V$ and $\overline{CE}_B \geq V_{CC} - 0.2V^{(5)}$ $V_{IN} \geq V_{CC} - 0.2V$ or $V_{IN} \leq 0.2V$ , Active Port Outputs Disabled, $f = f_{MAX}^{(1)}$	COM'L L	160	210	130	190	110	170	mA
			IND L	—	—	130	205	—	—	

5633 tbl 09

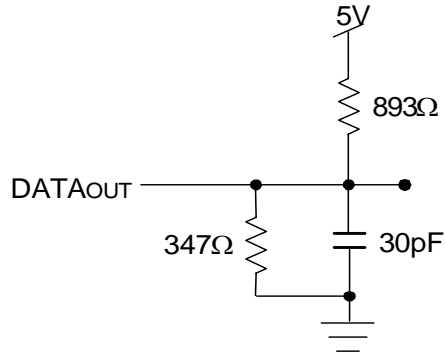
**NOTES:**

- At  $f = f_{MAX}$ , address and control lines (except Output Enable) are cycling at the maximum frequency clock cycle of  $1/t_{CYC}$ , using "AC TEST CONDITIONS" at input levels of GND to 3V.
- $f = 0$  means no address, clock, or control lines change. Applies only to input at CMOS level standby.
- Port "A" may be either left or right port. Port "B" is the opposite from port "A".
- $V_{CC} = 5V, T_A = 25^\circ C$  for Typ, and are not production tested.  $I_{CC} DC(f=0) = 150mA$  (Typ).
- $CE_X = V_{IL}$  means  $\overline{CE}_{0X} = V_{IL}$  and  $CE_{1X} = V_{IH}$   
 $CE_X = V_{IH}$  means  $\overline{CE}_{0X} = V_{IH}$  or  $CE_{1X} = V_{IL}$   
 $CE_X \leq 0.2V$  means  $\overline{CE}_{0X} \leq 0.2V$  and  $CE_{1X} \geq V_{CC} - 0.2V$   
 $CE_X \geq V_{CC} - 0.2V$  means  $\overline{CE}_{0X} \geq V_{CC} - 0.2V$  or  $CE_{1X} \leq 0.2V$   
"X" represents "L" for left port or "R" for right port.

### AC Test Conditions

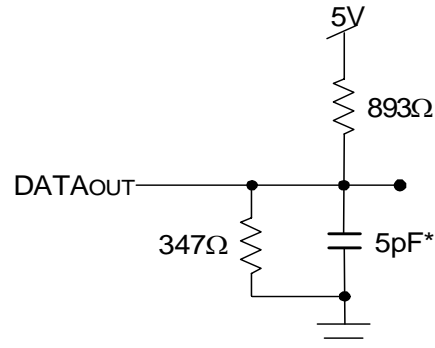
Input Pulse Levels	GND to 3.0V
Input Rise/Fall Times	2ns Max.
Input Timing Reference Levels	1.5V
Output Reference Levels	1.5V
Output Load	Figures 1, 2 and 3

5633 tbl 10



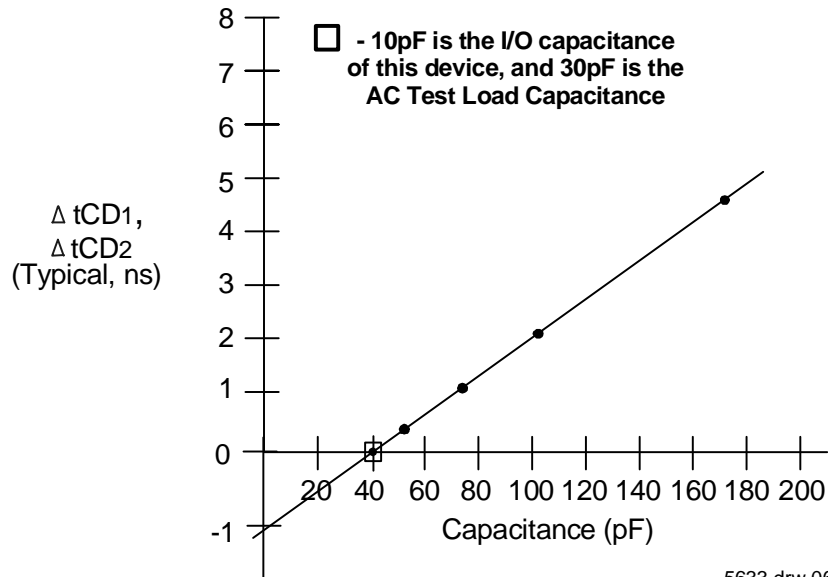
5633 drw 04

Figure 1. AC Output Test load.



5633 drw 05

Figure 2. Output Test Load  
(For  $t_{CKLZ}$ ,  $t_{CKHZ}$ ,  $t_{OLZ}$ , and  $t_{OHZ}$ ).  
\*Including scope and jig.



5633 drw 06

Figure 3. Typical Output Derating (Lumped Capacitive Load).

## AC Electrical Characteristics Over the Operating Temperature Range (Read and Write Cycle Timing)<sup>(3)</sup> ( $V_{CC} = 5V \pm 10\%$ , $T_A = 0^\circ\text{C}$ to $+70^\circ\text{C}$ )

Symbol	Parameter	709359/49L6 Com'l Only		709359/49L7 Com'l & Ind		709359/49L9 Com'l Only		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
t <sub>CYC1</sub>	Clock Cycle Time (Flow-Through) <sup>(2)</sup>	19	—	22	—	25	—	ns
t <sub>CYC2</sub>	Clock Cycle Time (Pipelined) <sup>(2)</sup>	10	—	12	—	15	—	ns
t <sub>CH1</sub>	Clock High Time (Flow-Through) <sup>(2)</sup>	6.5	—	7.5	—	12	—	ns
t <sub>CL1</sub>	Clock Low Time (Flow-Through) <sup>(2)</sup>	6.5	—	7.5	—	12	—	ns
t <sub>CH2</sub>	Clock High Time (Pipelined) <sup>(2)</sup>	4	—	5	—	6	—	ns
t <sub>CL2</sub>	Clock Low Time (Pipelined) <sup>(2)</sup>	4	—	5	—	6	—	ns
t <sub>r</sub>	Clock Rise Time	—	3	—	3	—	3	ns
t <sub>f</sub>	Clock Fall Time	—	3	—	3	—	3	ns
t <sub>SA</sub>	Address Setup Time	3.5	—	4	—	4	—	ns
t <sub>HA</sub>	Address Hold Time	0	—	0	—	1	—	ns
t <sub>SC</sub>	Chip Enable Setup Time	3.5	—	4	—	4	—	ns
t <sub>HC</sub>	Chip Enable Hold Time	0	—	0	—	1	—	ns
t <sub>SB</sub>	Byte Enable Setup Time	3.5	—	4	—	4	—	ns
t <sub>HB</sub>	Byte Enable Hold Time	0	—	0	—	1	—	ns
t <sub>SW</sub>	R/W Setup Time	3.5	—	4	—	4	—	ns
t <sub>HW</sub>	R/W Hold Time	0	—	0	—	1	—	ns
t <sub>SD</sub>	Input Data Setup Time	3.5	—	4	—	4	—	ns
t <sub>HD</sub>	Input Data Hold Time	0	—	0	—	1	—	ns
t <sub>SAD</sub>	$\overline{\text{ADS}}$ Setup Time	3.5	—	4	—	4	—	ns
t <sub>HAD</sub>	$\overline{\text{ADS}}$ Hold Time	0	—	0	—	1	—	ns
t <sub>SCN</sub>	$\overline{\text{CNTEN}}$ Setup Time	3.5	—	4	—	4	—	ns
t <sub>HCN</sub>	$\overline{\text{CNTEN}}$ Hold Time	0	—	0	—	1	—	ns
t <sub>SRST</sub>	$\overline{\text{CNTRST}}$ Setup Time	3.5	—	4	—	4	—	ns
t <sub>HRST</sub>	$\overline{\text{CNTRST}}$ Hold Time	0	—	0	—	1	—	ns
t <sub>OE</sub>	Output Enable to Data Valid	—	6.5	—	7.5	—	9	ns
t <sub>OLZ</sub>	Output Enable to Output Low-Z <sup>(1)</sup>	2	—	2	—	2	—	ns
t <sub>OHZ</sub>	Output Enable to Output High-Z <sup>(1)</sup>	1	7	1	7	1	7	ns
t <sub>CD1</sub>	Clock to Data Valid (Flow-Through) <sup>(2)</sup>	—	15	—	18	—	20	ns
t <sub>CD2</sub>	Clock to Data Valid (Pipelined) <sup>(2)</sup>	—	6.5	—	7.5	—	9	ns
t <sub>DC</sub>	Data Output Hold After Clock High	2	—	2	—	2	—	ns
t <sub>CKHZ</sub>	Clock High to Output High-Z <sup>(1)</sup>	2	9	2	9	2	9	ns
t <sub>CKLZ</sub>	Clock High to Output Low-Z <sup>(1)</sup>	2	—	2	—	2	—	ns
<b>Port-to-Port Delay</b>								
t <sub>CWDD</sub>	Write Port Clock High to Read Data Delay	—	24	—	28	—	35	ns
t <sub>CSS</sub>	Clock-to-Clock Setup Time	—	9	—	10	—	15	ns

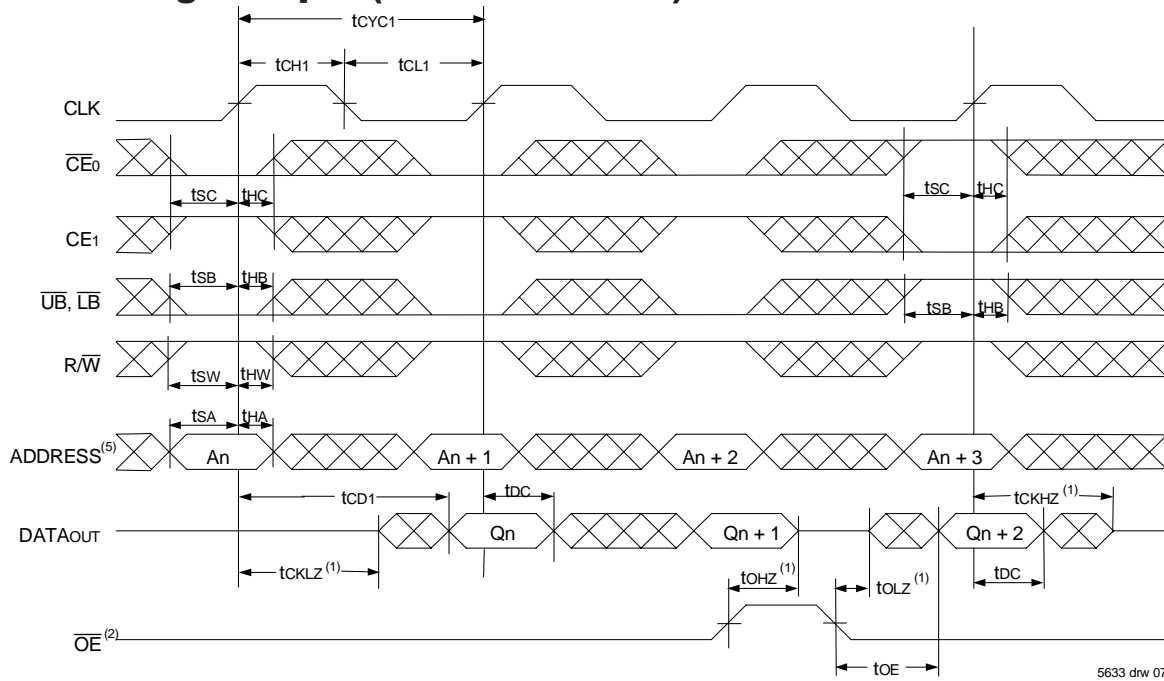
**NOTES:**

5633 tbl 11

- Transition is measured 0mV from Low or High-impedance voltage with the Output Test Load (Figure 2). This parameter is guaranteed by device characterization, but is not production tested.
- The Pipelined output parameters (t<sub>CYC2</sub>, t<sub>CD2</sub>) to either the Left or Right ports when  $\overline{\text{FT}}/\text{PIPE} = V_{IH}$ . Flow-Through parameters (t<sub>CYC1</sub>, t<sub>CD1</sub>) apply when  $\overline{\text{FT}}/\text{PIPE} = V_{IL}$  for that port.
- All input signals are synchronous with respect to the clock except for the asynchronous Output Enable ( $\overline{\text{OE}}$ ),  $\overline{\text{FT}}/\text{PIPER}$  and  $\overline{\text{FT}}/\text{PIPEL}$ .

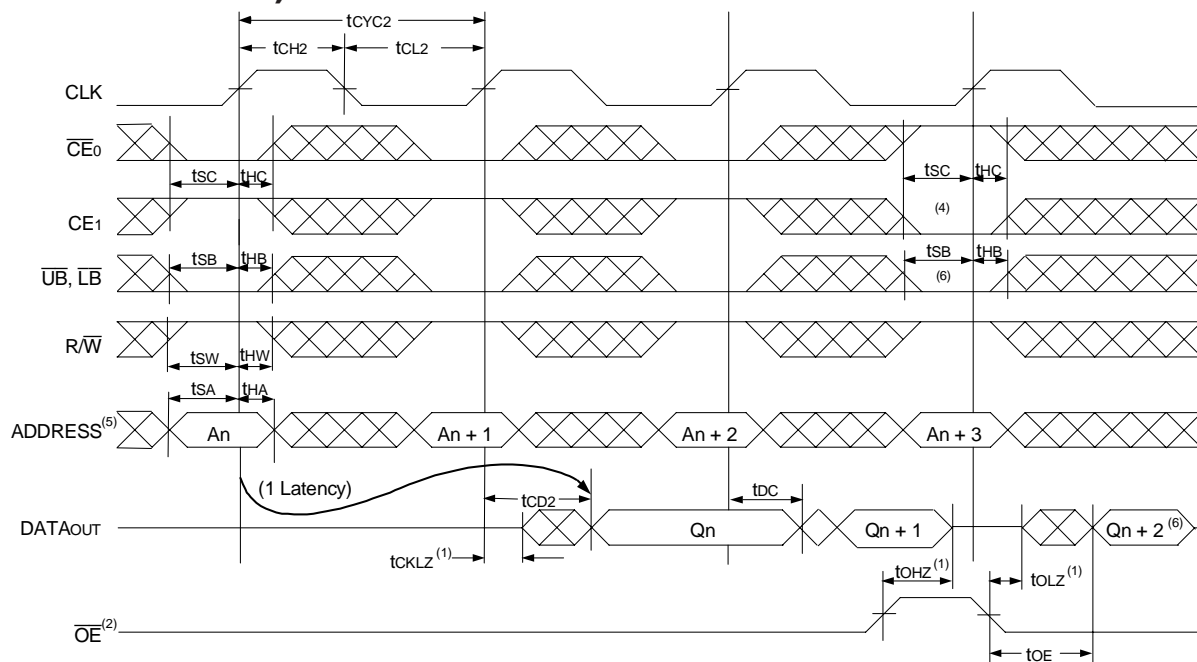


### Timing Waveform of Read Cycle for Flow-Through Output ( $\overline{FT}/PIPE"X" = V_{IL}$ )<sup>(3,7)</sup>



5633 drw 07

### Timing Waveform of Read Cycle for Pipelined Operation ( $\overline{FT}/PIPE"X" = V_{IH}$ )<sup>(3,7)</sup>

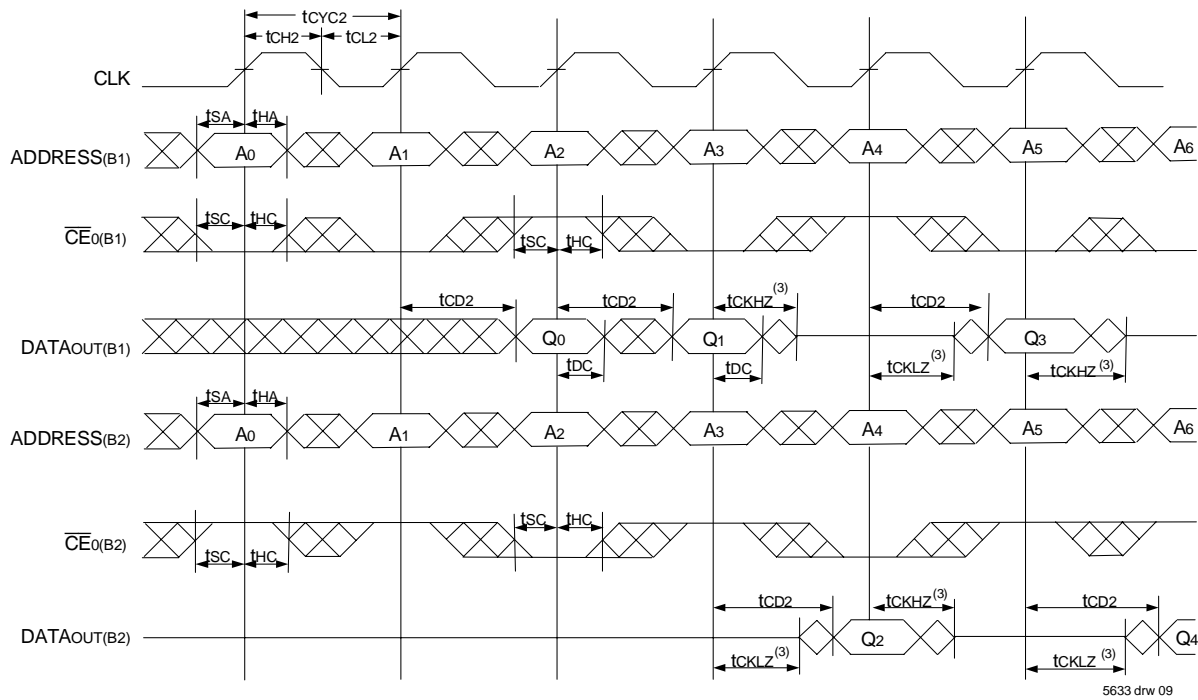


5633 drw 08

**NOTES:**

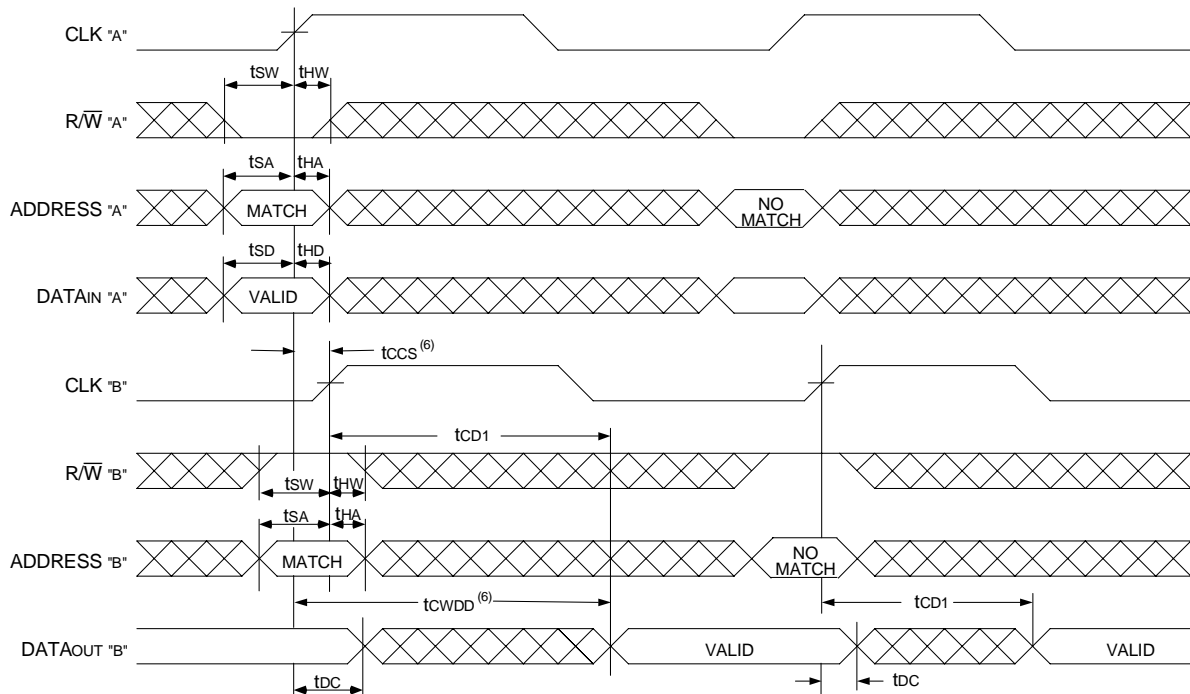
1. Transition is measured 0mV from Low or High-impedance voltage with the Output Test Load (Figure 2).
2.  $\overline{OE}$  is asynchronously controlled; all other inputs are synchronous to the rising clock edge.
3.  $\overline{ADS} = V_{IL}$ ,  $CNTEN$  and  $CNTRST = V_{IH}$ .
4. The output is disabled (High-Impedance state) by  $\overline{CE0} = V_{IH}$ ,  $CE1 = V_{IL}$ , following the next rising edge of the clock. Refer to Truth Table 1.
5. Addresses do not have to be accessed sequentially since  $\overline{ADS} = V_{IL}$  constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
6. If  $\overline{UB}$  or  $\overline{LB}$  was HIGH, then the Upper Byte and/or Lower Byte of  $DATA_{out}$  for  $Q_{n+2}$  would be disabled (High-Impedance state).
7. "X" here denotes Left or Right port. The diagram is with respect to that port.

### Timing Waveform of a Bank Select Pipelined Read<sup>(1,2)</sup>



5633 drw 09

### Timing Waveform of Write with Port-to-Port Flow-Through Read<sup>(4,5,7)</sup>

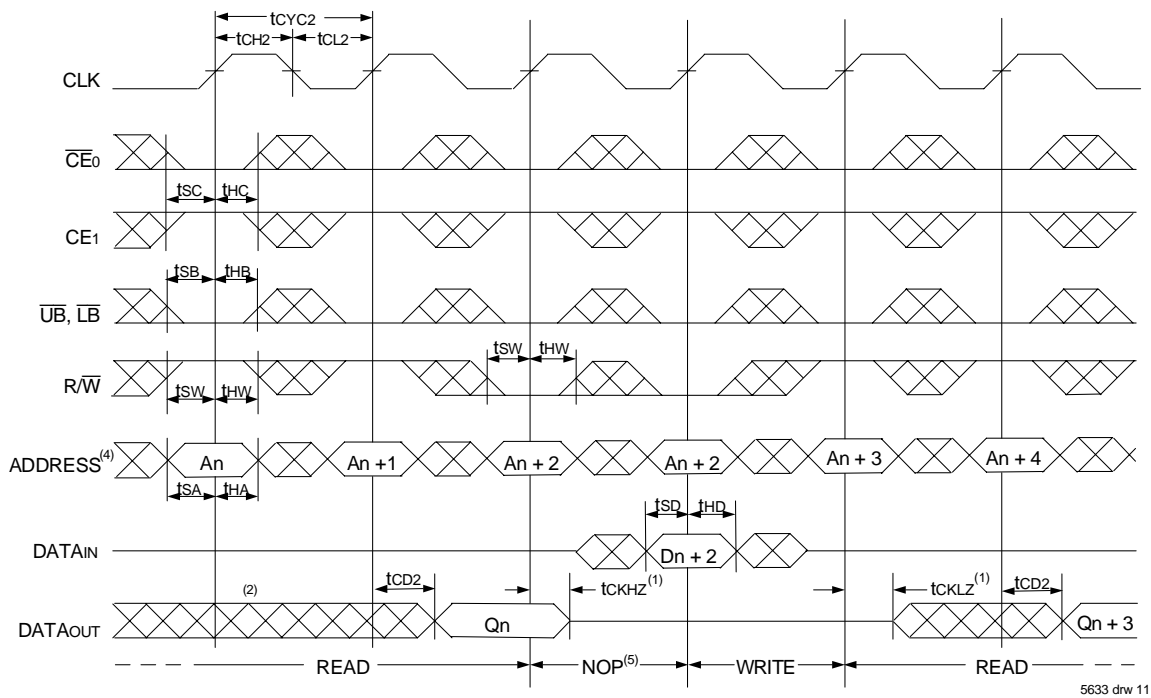


5633 drw 10

**NOTES:**

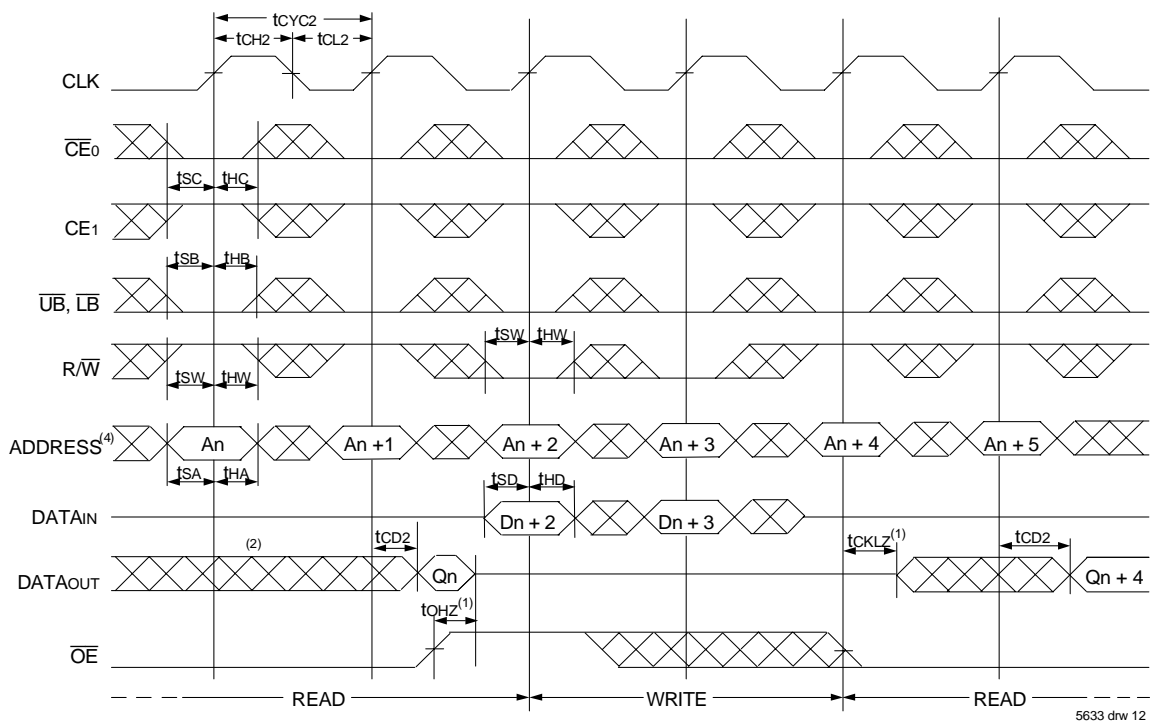
1. B1 Represents Bank #1; B2 Represents Bank #2. Each Bank consists of one IDT709359/49 for this waveform, and are setup for depth expansion in this example. ADDRESS(B1) = ADDRESS(B2) in this situation.
2.  $\overline{UB}$ ,  $\overline{LB}$ ,  $\overline{OE}$ , and  $\overline{ADS} = V_{IL}$ ;  $CE_{1(B1)}$ ,  $CE_{1(B2)}$ ,  $R/\overline{W}$ ,  $\overline{CNTEN}$ , and  $\overline{CNTRST} = V_{IH}$ .
3. Transition is measured 0mV from Low or High-impedance voltage with the Output Test Load (Figure 2).
4.  $\overline{CE}_0$ ,  $\overline{UB}$ ,  $\overline{LB}$ , and  $\overline{ADS} = V_{IL}$ ;  $CE_1$ ,  $\overline{CNTEN}$ , and  $\overline{CNTRST} = V_{IH}$ .
5.  $\overline{OE} = V_{IL}$  for the Right Port, which is being read from.  $\overline{OE} = V_{IH}$  for the Left Port, which is being written to.
6. If  $t_{CCS} \leq$  maximum specified, then data from right port READ is not valid until the maximum specified for  $t_{CWDD}$ . If  $t_{CCS} >$  maximum specified, then data from right port READ is not valid until  $t_{CCS} + t_{CD1}$ .  $t_{CWDD}$  does not apply in this case.
7. All timing is the same for both Left and Right ports. Port "A" may be either Left or Right port. Port "B" is the opposite from Port "A".

### Timing Waveform of Pipelined Read-to-Write-to-Read ( $\overline{OE} = V_{IL}$ )<sup>(3)</sup>



5633 drw 11

### Timing Waveform of Pipelined Read-to-Write-to-Read ( $\overline{OE}$ Controlled)<sup>(3)</sup>

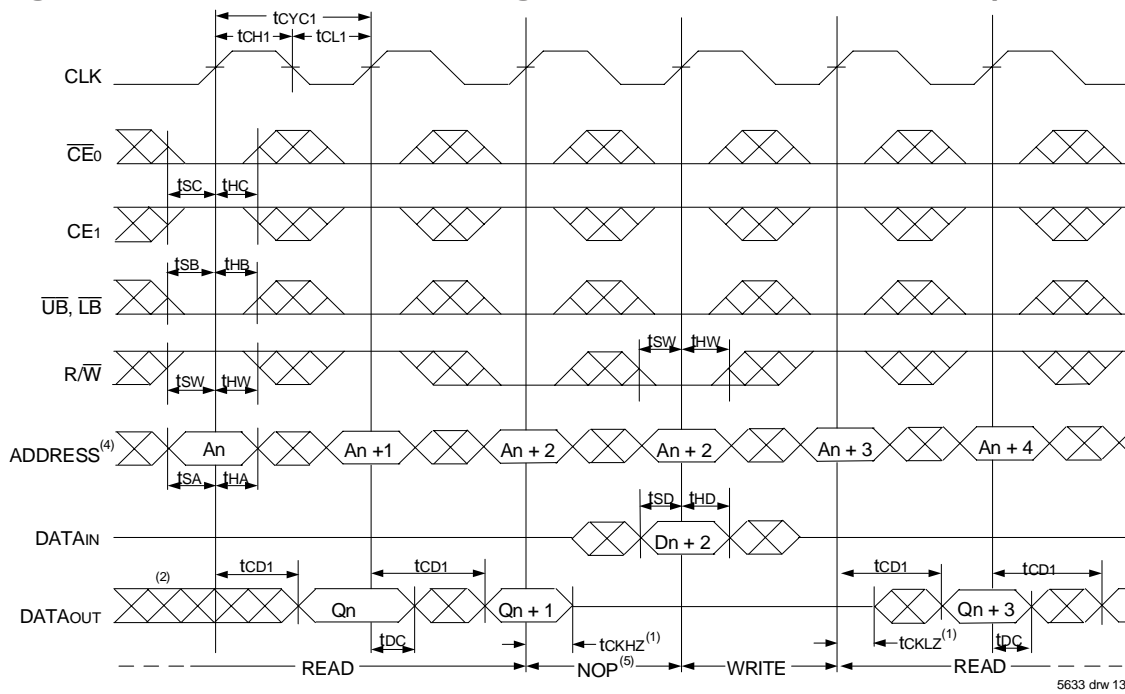


5633 drw 12

**NOTES:**

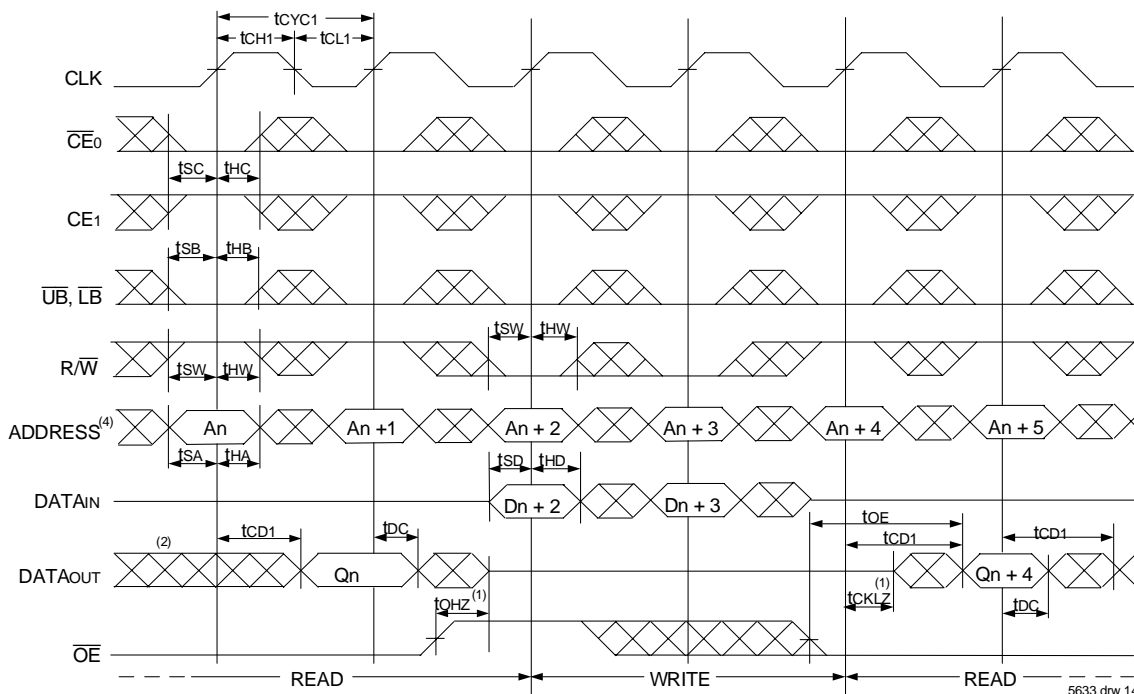
1. Transition is measured 0mV from Low or High-impedance voltage with the Output Test Load (Figure 2).
2. Output state (High, Low, or High-impedance) is determined by the previous cycle control signals.
3.  $\overline{CE}_0$ ,  $\overline{UB}$ ,  $\overline{LB}$ , and  $\overline{ADS} = V_{IL}$ ;  $\overline{CE}_1$ ,  $\overline{CNTEN}$ , and  $\overline{CNRST} = V_{IH}$ . "NOP" is "No Operation".
4. Addresses do not have to be accessed sequentially since  $\overline{ADS} = V_{IL}$  constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
5. "NOP" is "No Operation." Data in memory at the selected address may be corrupted and should be re-written to guarantee data integrity.

### Timing Waveform of Flow-Through Read-to-Write-to-Read ( $\overline{OE} = V_{IL}$ )<sup>(3)</sup>



5633 drw 13

### Timing Waveform of Flow-Through Read-to-Write-to-Read ( $\overline{OE}$ Controlled)<sup>(3)</sup>

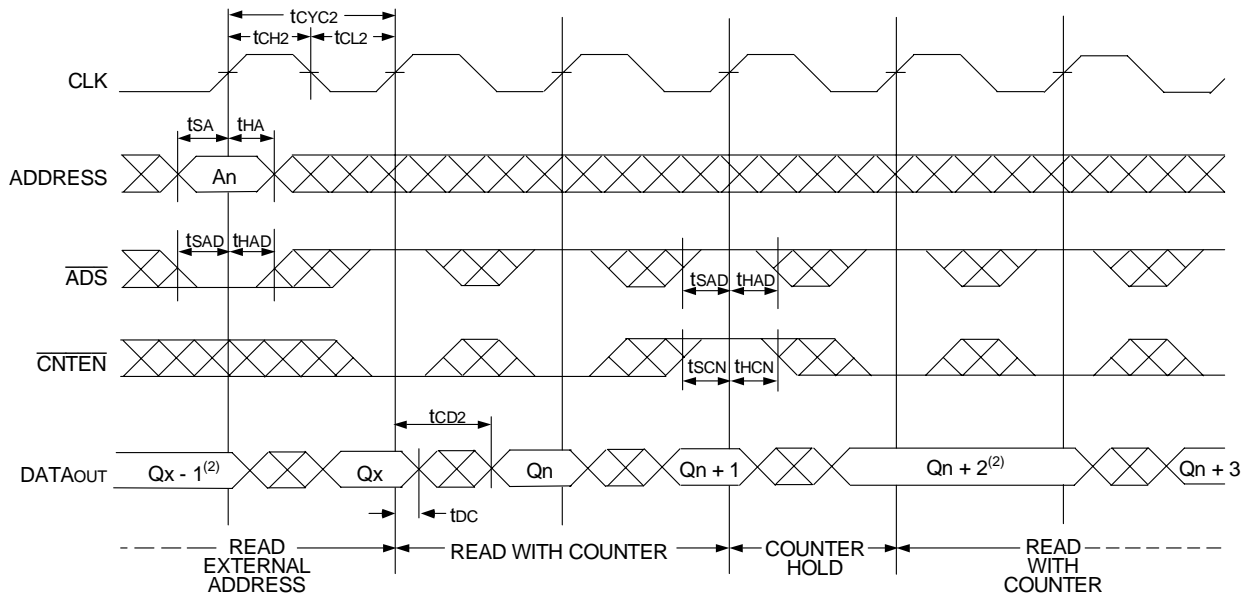


5633 drw 14

**NOTES:**

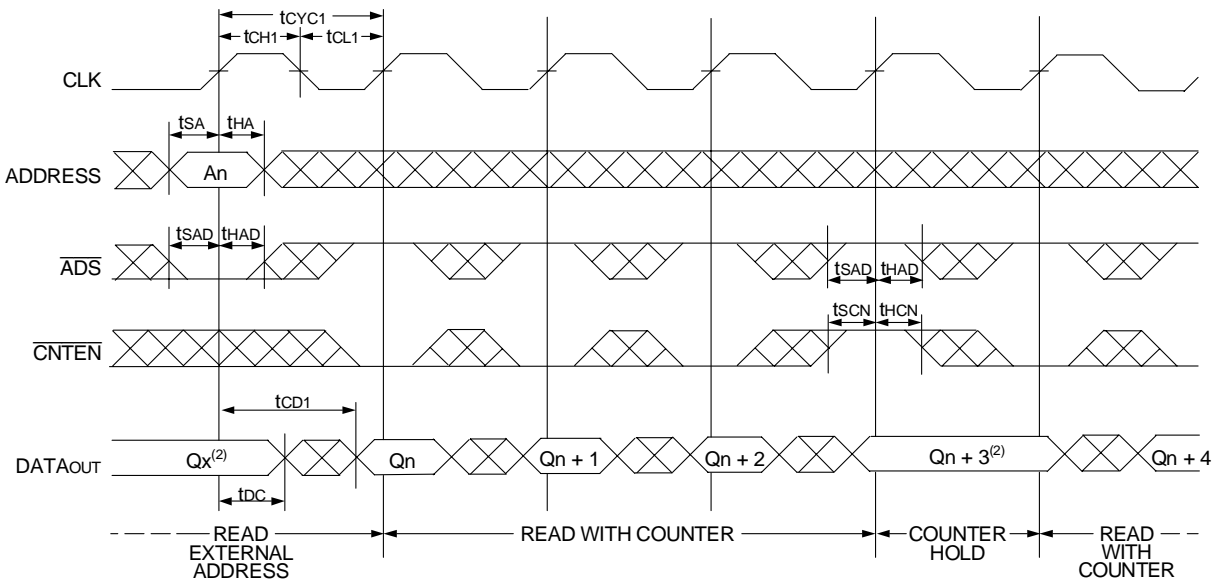
1. Transition is measured 0mV from Low or High-impedance voltage with the Output Test Load (Figure 2).
2. Output state (High, Low, or High-impedance) is determined by the previous cycle control signals.
3.  $\overline{CE0}$ ,  $\overline{UB}$ ,  $\overline{LB}$ , and  $\overline{ADS} = V_{IL}$ ;  $CE1$ ,  $\overline{CNTEN}$ , and  $\overline{CNRST} = V_{IH}$ . "NOP" is "No Operation".
4. Addresses do not have to be accessed sequentially since  $\overline{ADS} = V_{IL}$  constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
5. "NOP" is "No Operation." Data in memory at the selected address may be corrupted and should be re-written to guarantee data integrity.

### Timing Waveform of Pipelined Read with Address Counter Advance<sup>(1)</sup>



5633 drw 15

### Timing Waveform of Flow-Through Read with Address Counter Advance<sup>(1)</sup>

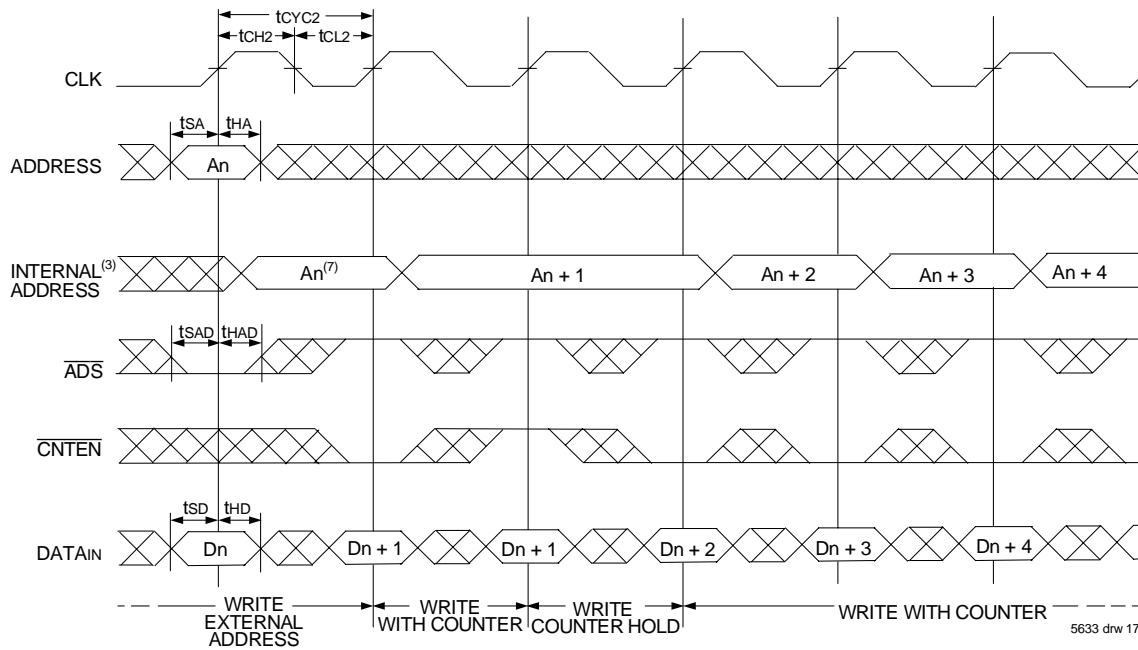


5633 drw 16

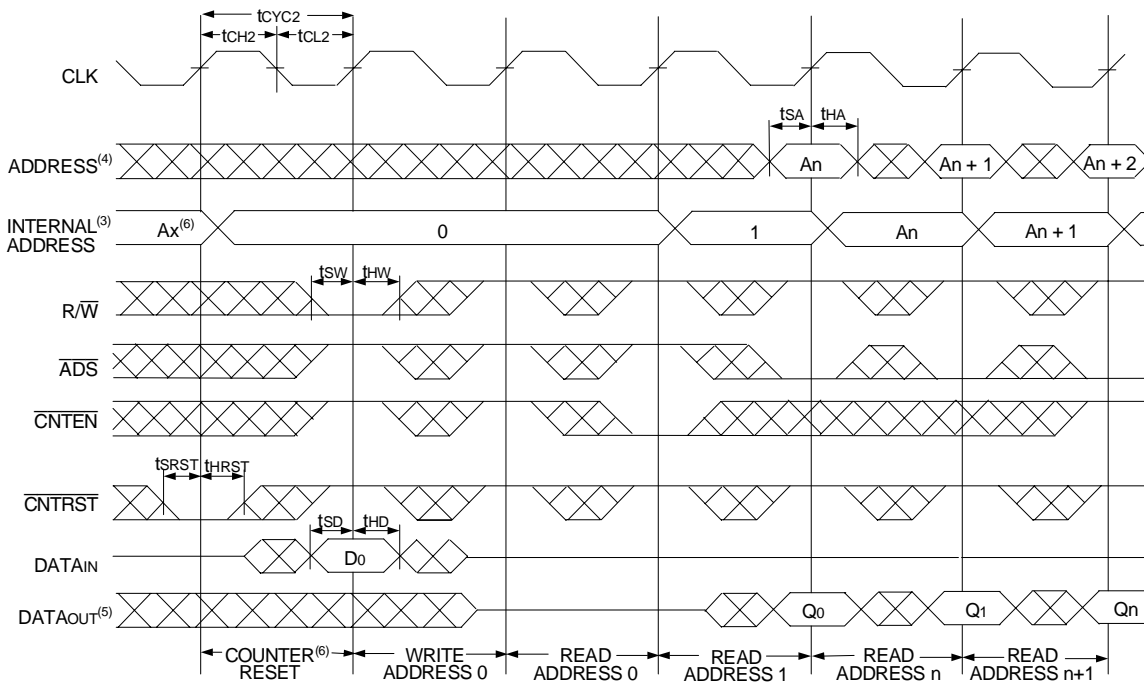
**NOTES:**

1.  $\overline{CE}_0$ ,  $\overline{OE}$ ,  $\overline{UB}$ , and  $\overline{LB} = V_{IL}$ ;  $CE_1$ ,  $R/\overline{W}$ , and  $\overline{CNTRST} = V_{IH}$ .
2. If there is no address change via  $\overline{ADS} = V_{IL}$  (loading a new address) or  $\overline{CNTEN} = V_{IL}$  (advancing the address), i.e.  $\overline{ADS} = V_{IH}$  and  $\overline{CNTEN} = V_{IH}$ , then the data output remains constant for subsequent clocks.

## Timing Waveform of Write with Address Counter Advance (Flow-Through or Pipelined Outputs)<sup>(1)</sup>



## Timing Waveform of Counter Reset (Pipelined Outputs)<sup>(2)</sup>



**NOTES:**

1.  $\overline{CE}_0, \overline{UB}, \overline{LB}$ , and  $R/\overline{W} = V_{IL}$ ;  $CE_1$  and  $\overline{CNTRST} = V_{IH}$ .
2.  $\overline{CE}_0, \overline{UB}, \overline{LB} = V_{IL}$ ;  $CE_1 = V_{IH}$ .
3. The "Internal Address" is equal to the "External Address" when  $\overline{ADS} = V_{IL}$  and equals the counter output when  $\overline{ADS} = V_{IH}$ .
4. Addresses do not have to be accessed sequentially since  $\overline{ADS} = V_{IL}$  constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
5. Output state (High, Low, or High-impedance) is determined by the previous cycle control signals.
6. No dead cycle exists during counter reset. A READ or WRITE cycle may be coincidental with the counter reset cycle.
7.  $\overline{CNTEN} = V_{IL}$  advances Internal Address from 'An' to 'An +1'. The transition shown indicates the time required for the counter to advance. The 'An +1' Address is written to during this cycle.

## A Functional Description

The IDT709359/49 provides a true synchronous Dual-Port Static RAM interface. Registered inputs provide minimal set-up and hold times on address, data, and all critical control inputs. All internal registers are clocked on the rising edge of the clock signal, however, the self-timed internal write pulse is independent of the LOW to HIGH transition of the clock signal.

An asynchronous output enable is provided to ease asynchronous bus interfacing. Counter enable inputs are also provided to stall the operation of the address counters for fast interleaved memory applications.

$\overline{CE}_0 = V_{IH}$  or  $CE_1 = V_{IL}$  for one clock cycle will power down the internal circuitry to reduce static power consumption. Multiple chip enables allow easier banking of multiple IDT709359/49's for depth expansion configurations. When the Pipelined output mode is enabled, two cycles are required with  $\overline{CE}_0 = V_{IL}$  and  $CE_1 = V_{IH}$  to re-activate the outputs.

## Depth and Width Expansion

The IDT709359/49 features dual chip enables (refer to Truth Table 1) in order to facilitate rapid and simple depth expansion with no requirements for external logic. Figure 4 illustrates how to control the various chip enables in order to expand two devices in depth.

The IDT709359/49 can also be used in applications requiring expanded width, as indicated in Figure 4. Since the banks are allocated at the discretion of the user, the external controller can be set up to drive the input signals for the various devices as required to allow for 36-bit or wider applications.

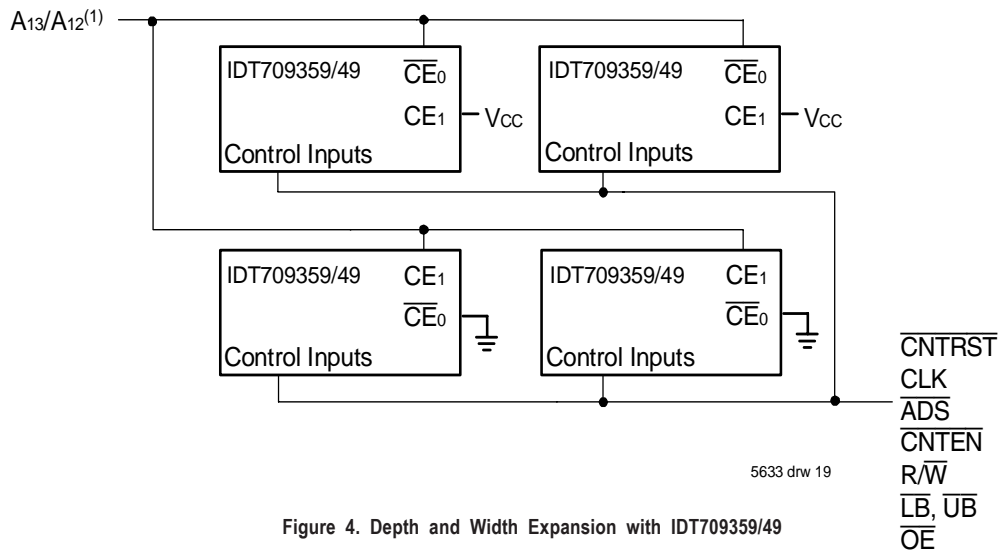
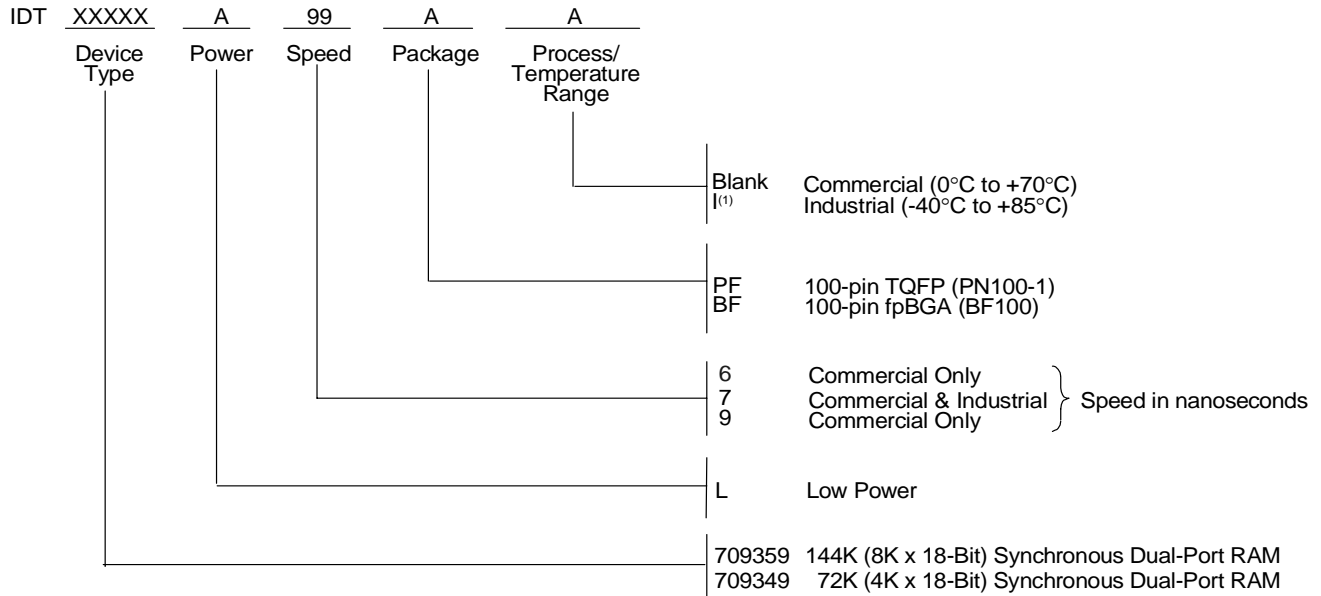


Figure 4. Depth and Width Expansion with IDT709359/49

**NOTE:**

1. A13 is for IDT709359, A12 is for IDT709349.

## Ordering Information



5633 drw 20

**NOTE:**

1. Contact your local sales office for industrial temp range for other speeds, packages and powers.

## IDT Clock Solution for IDT709359/49 Dual-Port

IDT Dual-Port Part Number	Dual-Port I/O Specifications		Clock Specifications				IDT PLL Clock Device	IDT Non-PLL Clock Device
	Voltage	I/O	Input Capacitance	Input Duty Cycle Requirement	Maximum Frequency	Jitter Tolerance		
709359/49	5	TTL	9pF	40%	100	150ps	FCT88915TT	49FCT805T 49FCT806T 74FCT807T

5633 tbl 12

## Datasheet Document History

07/08/02: Initial Public Release  
 08/18/03: Removed Preliminary status  
 Page 16 Added IDT Clock Solution Table



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